October 1998



SEMICONDUCTOR TM

### FDS6930A

## Dual N-Channel, Logic Level, PowerTrench<sup>™</sup> MOSFET

#### **General Description**

These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

#### Features

- Fast switching speed.
- Low gate charge (typical 5 nC).
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.

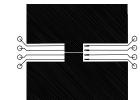
	ân (11)				
so	T-23 SuperSOT <sup>™</sup> -6	SuperSOT <sup>™</sup> -8	so-8	SOT-223	SOIC-16
	D1 D1 ED2 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5 ED5	S2 <sup>G2</sup>	[ [ [		4 3 2 1
	Te Maximum Ratings $T_A = 25^{\circ}$	C unless otherwise note	ed	FDS6930A	Units
mbol		C unless otherwise not	d	<b>FDS6930A</b> 30	Units V
m <b>bol</b>	Parameter	C unless otherwise note	ed		
m <b>bol</b>	Parameter Drain-Source Voltage	C unless otherwise not	ed	30	V
m <b>bol</b>	Parameter Drain-Source Voltage Gate-Source Voltage		ed	30 ±20	V V
rmbol ss ss	Parameter Drain-Source Voltage Gate-Source Voltage Drain Current - Continuous	(Note 1a)	ed	30 ±20 5.5	V V
rmbol ss ss	Parameter Drain-Source Voltage Gate-Source Voltage Drain Current - Continuous - Pulsed	(Note 1a)	ed	30 +20 5.5 20	V V A
vmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a)	ed	30 ±20 5.5 20 2	V V A W
rmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a) (Note 1) IN (Note 1a)	ed	30 +20 5.5 20 2 1.6	V V A W
rmbol ss ss	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation	(Note 1a) (Note 1) (Note 1a) (Note 1a) (Note 1b) (Note 1c)	ed	30 ±20 5.5 20 2 1.6 1	V V A W
rmbol ss ss T <sub>STG</sub>	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation         Power Dissipation for Single Operation	(Note 1a) (Note 1) (Note 1a) (Note 1a) (Note 1b) (Note 1c)		30 ±20 5.5 20 2 1.6 1 0.9	V           V           A           W           W
rmbol sss sss T <sub>STG</sub>	Parameter         Drain-Source Voltage         Gate-Source Voltage         Drain Current - Continuous         - Pulsed         Power Dissipation for Dual Operation         Power Dissipation for Single Operation         Operating and Storage Temperature I	(Note 1a) (Note 1) n (Note 1a) (Note 1b) (Note 1c) Range	ed	30 ±20 5.5 20 2 1.6 1 0.9	V           V           A           W           W

© 1998 Fairchild Semiconductor Corporation

Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHAR	ACTERISTICS	·		•	•	•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$		30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{D}$ = 250 µA, Referenced t	o 25 °C		20		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$				1	μA
			T <sub>J</sub> = 55°C			10	μA
	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate - Body Leakage, Reverse	$V_{gs} = -20 \text{ V}, \text{ V}_{ds} = 0 \text{ V}$				-100	nA
ON CHARA	CTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1	1.5	3	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_D = 250 \ \mu$ A, Referenced to $25 \ ^{\circ}$ C			-4		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 5.5 \text{ A}$			0.032	0.04	Ω
			T <sub>J</sub> =125°C		0.048	0.068	
		$V_{GS} = 4.5 \text{ V}, \ \text{I}_{D} = 4.8 \text{ A}$	•		0.044	0.055	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$		20			А
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 5.5 \text{ A}$			12		S
DYNAMIC (	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$			460		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz			115		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				45		pF
SWITCHING	CHARACTERISTICS (Note 2)			•			
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = 15 \text{ V}, \ I_{D} = 1 \text{ A}$			5	11	ns
ţ,	Turn - On Rise Time	$V_{\rm GS} = 10 \ V \ , \ R_{\rm GEN} = 6 \ \Omega$			8	17	ns
t <sub>D(off)</sub>	Turn - Off Delay Time				17	28	ns
t <sub>r</sub>	Turn - Off Fall Time				13	24	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 5 V, I_{D} = 5.5 A,$			5	7	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$			2		nC
Q <sub>gd</sub>	Gate-Drain Charge				0.9		nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MA	XIMUM RATINGS					
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current					1.3	А
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 1.3 A$ (Note	2)			1.2	V

Notes:

1. R<sub>g,k</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>g,k</sub> is guaranteed by design while R<sub>g,k</sub> is determined by the user's board design.



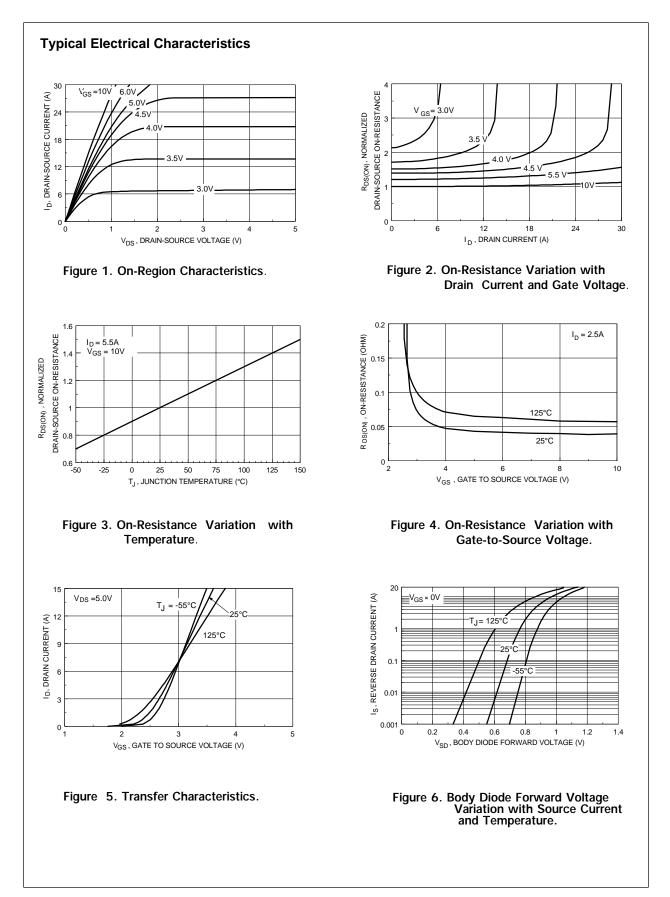


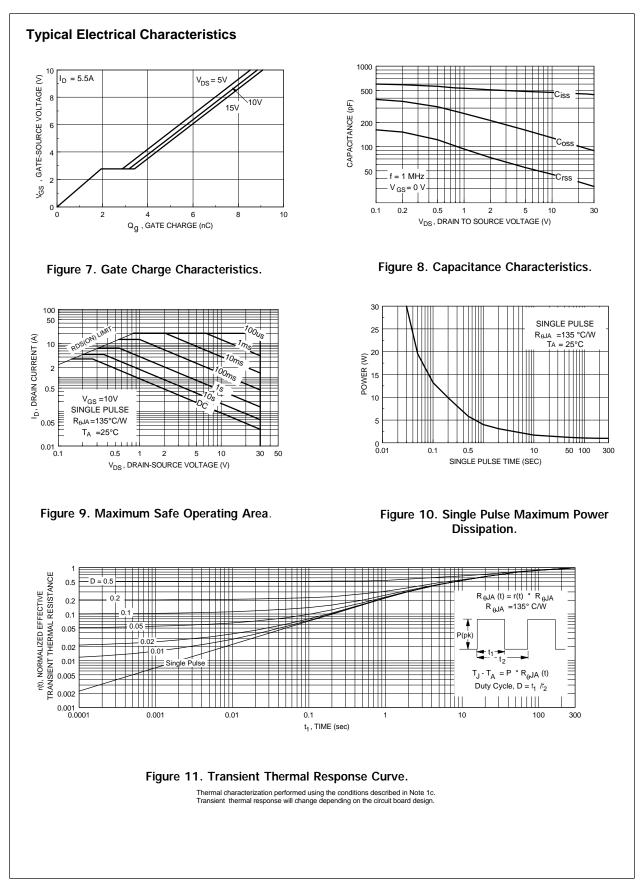
000 

b. 125°C/W on a 0.02 in<sup>2</sup> pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2.0%.





#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx<sup>TM</sup> CoolFET<sup>TM</sup> CROSSVOLT<sup>TM</sup> E<sup>2</sup>CMOS<sup>TM</sup> FACT<sup>TM</sup> FACT Quiet Series<sup>TM</sup> FAST<sup>®</sup> FAST<sup>®</sup> FASTr<sup>TM</sup> GTO<sup>TM</sup> HiSeC<sup>TM</sup> ISOPLANAR<sup>™</sup> MICROWIRE<sup>™</sup> POP<sup>™</sup> PowerTrench<sup>™</sup> QFET<sup>™</sup> QS<sup>™</sup> Quiet Series<sup>™</sup> SuperSOT<sup>™</sup>-3 SuperSOT<sup>™</sup>-6 SuperSOT<sup>™</sup>-8

TinyLogic™ UHC™ VCX™

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user. 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

# **Mouser Electronics**

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: